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If you want to conduct a Number Search, please click on the button to the right.

[Number Search](#)

Applicant, Title of invention, Abstract — e.g. computer semiconductor

If you use the AND/OR operation, please leave a **SPACE** between keywords.

One letter word or **Stopwords** are not searchable.

[AND](#)

AND

[AND](#)

AND

[AND](#)

AND

Date of publication of application — e.g. 19980401 - 19980405

 -

AND

IPC — e.g. D01B7/04 A01C11/02

If you use the OR operation, please leave a **SPACE** between keywords.

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worm-arq

In: All Fields

And

In: All Fields

And

In: All Fields

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Note: This function returns plural and suffixed forms of the keyword(s).

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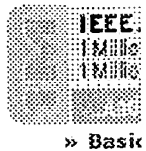
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"selective repeat" In: All Fields

And

"go back n" In: All Fields

And

In: All Fields

Search

Clear

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